

**Search Notes**

Application/Control No.

10/646,152

Examiner

Shih-Chao Chen

Applicant(s)/Patent under  
Reexamination

3PARK ET AL.

Art Unit

2821

**SEARCHED**

Class	Subclass	Date	Examiner
343	700MS, 702, 724, 725, 793, 853	3/5/2005	CHEN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (See attached printout)	2/3/2005	CHEN